# onsemi

## N-Channel Logic Level Enhancement Mode Field Effect Transistor

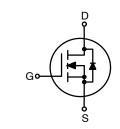
## **BSS123**

#### **General Description**

These N-Channel enhancement mode field effect transistors are produced using **onsemi's** proprietary, high cell density, DMOS technology. These products have been designed to minimize on-state resistance while provide rugged, reliable, and fast switching performance. These products are particularly suited for low voltage, low current applications such as small servo motor control, power MOSFET gate drivers, and other switching applications.

#### Features

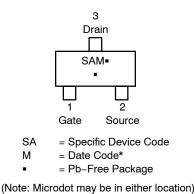
- 0.17 A, 100 V
  - $R_{DS(on)} = 6 \Omega @ V_{GS} = 10 V$
  - $R_{DS(on)} = 10 \ \Omega @ V_{GS} = 4.5 \ V$
- High Density Cell Design for Extremely Low RDS(on)
- Rugged and Reliable
- Compact Industry Standard SOT-23 Surface Mount Package
- This Device is Pb–Free and Halogen Free





SOT-23-3 CASE 318-08

#### MARKING DIAGRAM



\*Date Code orientation and/or position may vary depending upon manufacturing location.

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
BSS123,	SOT-23-3	3000 /
BSS123-G	(Pb-Free)	Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

Symbol	Parameter	Ratings	Unit
V <sub>DSS</sub>	Drain-Source Voltage	100	V
V <sub>GSS</sub>	Gate-Source Voltage	±20	
I <sub>D</sub>	Drain Current – Continuous (Note 1)	0.17	А
	Drain Current – Pulsed (Note 1)	0.68	
PD	Maximum Power Dissipation (Note 1)	0.36	W
	Derate Above 25°C	2.8	mW/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range	–55 to +150	
ΤL	Maximum Lead Temperature for Soldering Purposes, 1/16" from Case for 10 s	300	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL CHARACTERISTICS $T_A$ = 25°C unless otherwise noted.

Symbol	Parameter	Ratings	Unit
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1)	350	°C/W

### **ELECTRICAL CHARACTERISTICS** $T_A = 25^{\circ}C$ unless otherwise noted.

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
OFF CHARA	CTERISTICS					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS}$ = 0 V, $I_D$ = 250 $\mu$ A	100	-	-	V
$\frac{\Delta \text{BV}_{\text{DSS}}}{\Delta \text{T}_{\text{J}}}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, Referenced to 25°C	-	97	-	mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS}$ = 100 V, $V_{GS}$ = 0 V	-	-	1	μΑ
		$V_{DS}$ = 100 V, $V_{GS}$ = 0 V, T <sub>J</sub> = 125°C	-	-	60	
		$V_{DS}$ = 20 V, $V_{GS}$ = 0 V	-	-	10	nA
I <sub>GSS</sub>	Gate-Body Leakage	$V_{GS} = \pm 20$ V, $V_{DS} = 0$ V	-	-	±50	nA

#### **ON CHARACTERISTICS** (Note 2)

V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 1 \text{ mA}$	0.8	1.7	2	V
$\frac{\Delta V_{\text{GS(th)}}}{\Delta T_{\text{J}}}$	Gate Threshold Voltage Temperature Coefficient	$I_D = 1$ mA, Referenced to 25°C	-	-2.7	-	mV/°C
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 0.17 A	-	1.2	6	Ω
		$V_{GS}$ = 4.5 V, I <sub>D</sub> = 0.17 A	-	1.3	10	
		$V_{GS}$ = 10 V, I <sub>D</sub> = 0.17 A, T <sub>J</sub> = 125°C	-	2.2	12	
I <sub>D(on)</sub>	On-State Drain Current	$V_{GS}$ = 10 V, $V_{DS}$ = 5 V	0.68	-	-	А
<b>9</b> FS	Forward Transconductance	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 0.17 \text{ A}$	0.08	0.8	-	S

#### DYNAMIC CHARACTERISTICS

C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 1.0 MHz	-	73	-	pF
C <sub>oss</sub>	Output Capacitance		-	7	-	
C <sub>rss</sub>	Reverse Transfer Capacitance		-	3.4	-	
R <sub>G</sub>	Gate Resistance	V <sub>GS</sub> = 15 mV, f = 1.0 MHz	-	2.2	-	Ω

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#### **ELECTRICAL CHARACTERISTICS** $T_A = 25^{\circ}C$ unless otherwise noted. (continued)

Parameter	Test Conditions	Min	Тур	Max	Unit
CHARACTERISTICS (Note 2)					
Turn-On Delay Time	$V_{DD} = 30 \text{ V}, \text{ I}_{D} = 0.28 \text{ A},$	-	1.7	3.4	ns
Turn–On Rise Time	$v_{GS} = 10 v, R_{GEN} = 0.02$	-	9	18	
Turn-Off Delay Time		-	17	31	
Turn–Off Fall Time	]	-	2.4	5	1
Total Gate Charge	$V_{DS} = 30 \text{ V}, \text{ I}_{D} = 0.22 \text{ A},$	-	1.8	2.5	nC
Gate-Source Charge	$v_{GS} = 10 v$	_	0.2	-	
Gate-Drain Charge		-	0.3	-	
	CHARACTERISTICS (Note 2) Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge	CHARACTERISTICS (Note 2)Turn-On Delay Time $V_{DD} = 30 \text{ V}, \text{ I}_D = 0.28 \text{ A},$ $V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ Turn-On Rise Time $V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ Turn-Off Delay Time $V_{DS} = 30 \text{ V}, \text{ I}_D = 0.22 \text{ A},$ $V_{GS} = 10 \text{ V}$ Total Gate Charge $V_{DS} = 30 \text{ V}, \text{ I}_D = 0.22 \text{ A},$ $V_{GS} = 10 \text{ V}$	CHARACTERISTICS (Note 2)Turn-On Delay Time $V_{DD} = 30 \text{ V}, \text{ I}_D = 0.28 \text{ A},$ $V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ -Turn-On Rise Time-Turn-Off Delay Time-Turn-Off Fall Time-Total Gate Charge $V_{DS} = 30 \text{ V}, \text{ I}_D = 0.22 \text{ A},$ $V_{GS} = 10 \text{ V}$ Gate-Source Charge-	Turn-On Delay Time $V_{DD} = 30 \text{ V}, \text{ I}_D = 0.28 \text{ A},$ -       1.7         Turn-On Rise Time $V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ -       9         Turn-Off Delay Time       -       17         Turn-Off Fall Time       -       2.4         Total Gate Charge $V_{GS} = 10 \text{ V}, \text{ I}_D = 0.22 \text{ A},$ -       1.8         Gate-Source Charge       -       0.2       -       0.2	Turn-On Delay Time $V_{DD} = 30 \text{ V}, I_D = 0.28 \text{ A}, V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$ $ 1.7$ $3.4$ Turn-On Rise Time $V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$ $ 9$ $18$ Turn-Off Delay Time $ 1.7$ $3.4$ Turn-Off Fall Time $ 2.4$ $5$ Total Gate Charge $V_{DS} = 30 \text{ V}, I_D = 0.22 \text{ A}, V_{GS} = 10 \text{ V}$ $ 1.8$ $2.5$ Gate-Source Charge $V_{GS} = 10 \text{ V}$ $ 0.2$ $-$

DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS

۱ <sub>S</sub>	Maximum Continuous Drain-Source Diode Forward Current		-	-	0.17	А
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	$V_{GS}$ = $0$ V, I_S = 0.44 A (Note 2)	-	0.8	1.3	V
t <sub>rr</sub>	Diode Reverse Recovery Time	$I_F = 0.17 \text{ A},  d_{if}/d_t = 100 \text{ A}/\mu\text{s}$	-	11	-	ns
Q <sub>rr</sub>	Diode Reverse Recovery Charge		-	3	-	nC

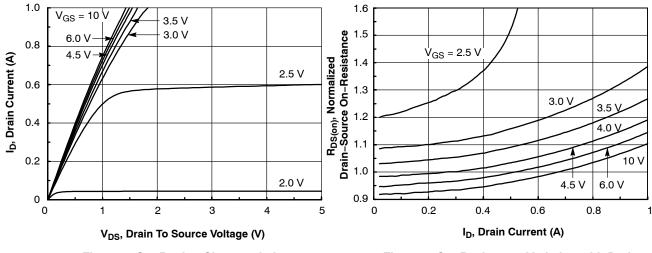
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

 R<sub>0JA</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R<sub>0JA</sub> is guaranteed by design while R<sub>0JA</sub> is determined by the user's board design.

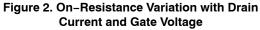
a) 350°C/W when mounted on a minimum pad.

2. Pulse Test: Pulse Width  $\leq$  300  $\mu$ s, Duty Cycle  $\leq$  2.0%

#### **TYPICAL CHARACTERISTICS**

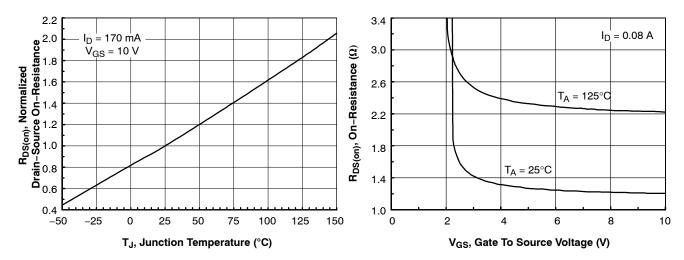




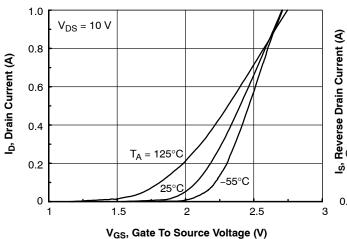


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#### TYPICAL CHARACTERISTICS (continued)









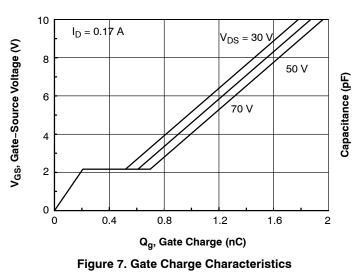
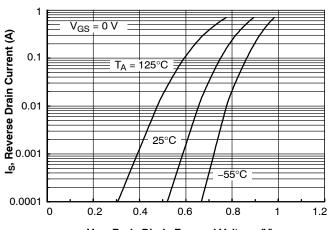
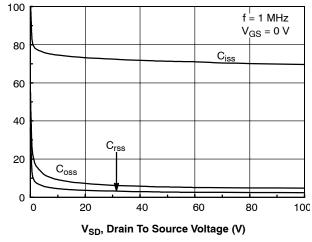


Figure 4. On–Resistance Variation with Gate–to–Source Voltage



V<sub>SD</sub>, Body Diode Forward Voltage (V)

Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature





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#### TYPICAL CHARACTERISTICS (continued)

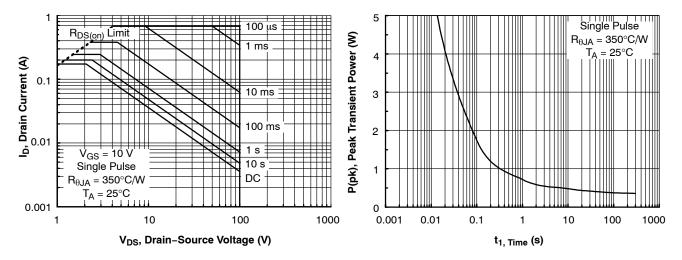




Figure 10. Single Pulse Maximum Power Dissipation

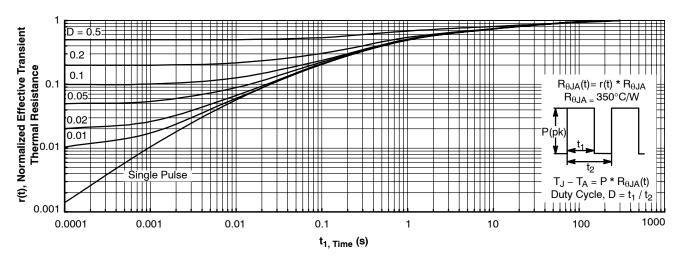


Figure 11. Transient Thermal Response Curve

Thermal characterization performed using the conditions described in Note 1a. Transient thermal response will change depending on the circuit board design.





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